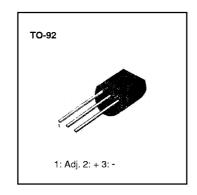
# PROGRAMMABLE SHUNT REGULATOR

The LM336-2.5/B integrated Circuits are precision 2.5V shunt regulators. The monolithic IC voltage references operates as a low temperature coefficient 2.5V zener with 0.2 $\Omega$  dynamic impedance. A third terminal on the KA336-2.5/B allow the reference voltage and temperature coefficient to be trimmed easily.

LM3362.5/B are useful as a precision 2.5V low voltage reference for digital voltmeters, power supplies or op amp circuitry. The 2.5V make it convenient to obtain a stable reference from low voltage supplies. Further, since the LM336-2.5/B operate as shunt regulators, they can be used as either a positive or negative voltage reference.



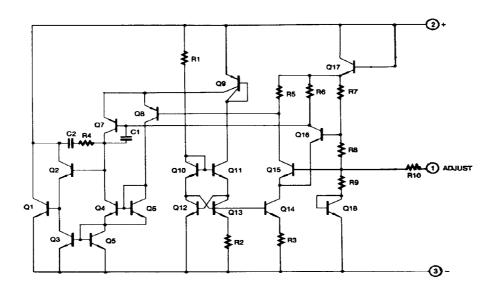
# **FEATURES**

- Low temperature coefficient
- Guaranteed temperature stability 4mV typical
- ullet 0.2  $\Omega$  dynamic impedance
- ±1.0% initial tolerance available.
- Easily trimmed for minimum temperature drift

# **ORDERING INFORMATION**

Device	Package	Operating Temperature				
LM336Z-2.5		0 ~ +70°C				
LM336Z-2.5B	TO-92					
LM236Z-2.5		-25 ~ +85°C				

# **SCHEMATIC DIAGRAM**





# LM336-2.5/B/LM236-2.5 (KA336-2.5, KA236-2.5) PROGRAMMABLE SHUNT REGULATOR

# **ABSOLUTE MAXIMUM RATINGS**

Characteristic	Symbol	Value	Unit	
Reverse Current	I <sub>R</sub>	15	m <b>A</b>	
Forward Current	l <sub>F</sub>	10	m <b>A</b>	
Operating Temperature Range LM336-2.5/B LM236-2.5	$T_{OPR}$	0 ~ + 70 - 25 ~ +85	ဂံ ဂံ	
Storage Temperature Range	T <sub>STG</sub>	- 60 ~ + 150	°C	

# $\textbf{ELECTRICAL CHARACTERISTICS} \ (T_{MIN} < T_{A} \ < T_{MAX}, \ unless \ otherwise \ specified)$

Characteristic Symbo	Completed Total Completions	LM336/236			LM336B				
	Symbol	Test Conditions	Min	Тур	Max	Min	Тур	Max	
Reverse Breakdown Voltage	$V_R$	$T_A = +25^{\circ}C$ $I_R = 1 \text{mA}$	2.44	2.49	2.54	2.465	2.49	2.515	٧
Reverse Breakdown Change with Current	$\Delta V_R/\Delta I_R$	$T_A = +25$ °C 400μA ≤ $I_R$ ≤ 10mA		2.6	6		2.6	10	mV
Reverse Dynamic Impedance	$Z_D$	$T_A = +25$ °C $I_R = 1$ mA		0.2	0.6		0.2	1	Ω
Temperature Stability	ST <sub>T</sub>	$I_R = 1mA$ $T_{MIN} \le T_A \le T_{MAX}$		1.8	6		1.8	6	mV
Reverse Breakdown Change with Current	$\Delta V_R/\Delta I_R$	$T_{MIN} \le T_A \le T_{MAX}$ $400\mu A \le I_R \le 10mA$		3	10		3	12	mV
Reverse Dynamic Impedance	$Z_D$	$I_R = 1mA$ $T_{MIN} \le T_A \le T_{MAX}$		0.4	1		0.4	1.4	Ω
Long Term Stability	ST	$I_R = 1 \text{mA}$ $T_{MIN} \le T_A \le T_{MAX}$		20			20		ppm

$$\begin{split} LM236: T_{MIN} &= \text{-}25^{\circ}C, \ T_{MAX} = \text{+}85^{\circ}C \\ LM336: T_{MIN} &= 0^{\circ}C, \ T_{MAX} = \text{+}70^{\circ}C \end{split}$$



# TYPICAL PERFORMANCE CHARACTERISTICS

Fig. 1. Reverse Voltage Change

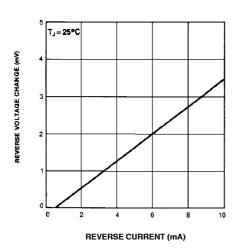


Fig. 2 Reverse Characteristics

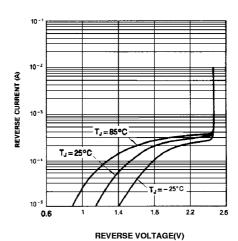


Fig. 3 Temperature Drift

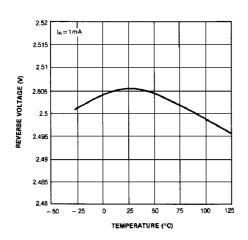
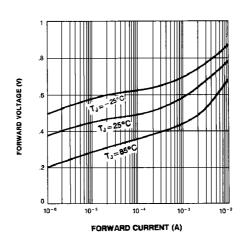


Fig. 4 Forward Characteristics





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E<sup>2</sup>CMOS<sup>™</sup> PowerTrench<sup>™</sup>

FACT<sup>TM</sup> QS<sup>TM</sup>

 $\begin{array}{lll} \text{FACT Quiet Series}^{\text{TM}} & \text{Quiet Series}^{\text{TM}} \\ \text{FAST}^{\text{\$}} & \text{SuperSOT}^{\text{TM}}\text{-3} \\ \text{FASTr}^{\text{TM}} & \text{SuperSOT}^{\text{TM}}\text{-6} \\ \text{GTO}^{\text{TM}} & \text{SuperSOT}^{\text{TM}}\text{-8} \\ \text{HiSeC}^{\text{TM}} & \text{TinyLogic}^{\text{TM}} \\ \end{array}$ 

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